

**Notice of References Cited**

 Application/Control No.  
 09/816,964

 Applicant(s)/Patent Under  
 Reexamination  
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 Art Unit  
 1753

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-3,494,846	02-1970	Arquembourg, P.C.	436/516
	B	US-3,930,973	01-1976	Nerenberg, Samuel T.	204/546
	C	US-3,947,345	03-1976	Grandine et al.	204/617
	D	US-4,190,517	02-1980	Monthony et al.	204/621
	E	US-4,310,407	01-1982	Kaneko et al.	204/641
	F	US-4,814,057	03-1989	Nishizawa, Hideyuki	204/621
	G	US-4,911,816	03-1990	Love et al.	204/614
	H	US-5,074,981	12-1991	Fairfield, Frederic R.	204/466
	I	US-6,328,870	12-2001	Provonchee et al.	204/616
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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